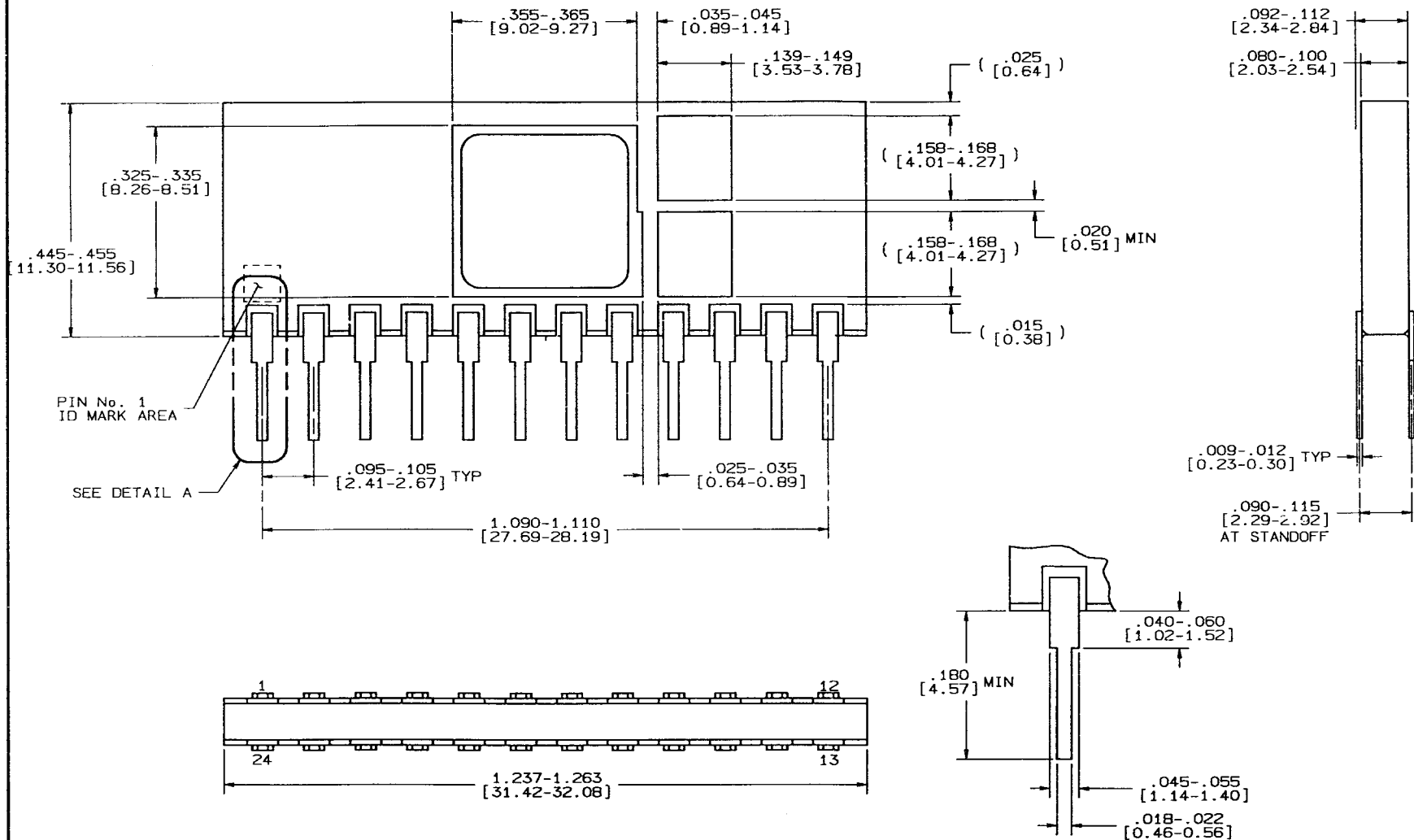


REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
A	RELEASE TO DOCUMENT CONTROL	09706	04/30/93	DEG/s/



DETAIL A TYP
SCALE: 10X

NOTES: UNLESS OTHERWISE SPECIFIED

- ALL EXPOSED METAL AND METALIZED AREAS TO BE PLATED 60 MICROINCHES/1.52 MICROMETERS MINIMUM GOLD OVER 100 MICROINCHES/2.54 MICROMETERS MINIMUM NICKLE.
- NO JEDEC REGISTRATION AS OF 04/20/93.

CONTROLLING DIMENSION IS INCHES			
APPROVALS	DATE	NATIONAL SEMICONDUCTOR CORPORATION	
DRAWN D.E. GRADY	04/30/93	2900 Semiconductor Drive, Santa Clara, CA 95052-8090	
DFTG. CHK. H. H. H.	5/6/93	SINGLE INLINE PACKAGE, HERMETIC, 24 LEAD	
ENGR. CHK. S. H. H.	5/3/93		
APPROVAL			
PROJECTION	SCALE	SIZE	DRAWING NUMBER
	N/A	C	MKT-CP24A
INCH [mm]	DO NOT SCALE DRAWING	SHEET	1 OF 1